CRMDTU3136K

N-Channel 20V, 246mΩ Typ. Power MOSFET

Description

Features

• 20V, 0.5A

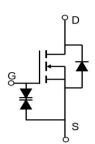
 $R_{DS(ON)}$ Typ = 246m Ω @ V_{GS} = 4.5V

 $R_{DS(ON)}$ Typ = 368m Ω @ V_{GS} = 2.5V

 $R_{DS(ON)}$ Typ = 619m Ω @ V_{GS} = 1.8V

- Advanced Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- Lead Free

• ESD Protected: 2KV



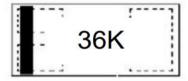


Application

- Load Switch
- PWM Application
- Power Management







Marking and Pin Assignment

Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMDTU3136K	36K	DFN1006-3L	TAPING	7"	10000	400000

Absolute Maximum Ratings (@ T_J = 25°C unless otherwise specified)

Symbol	Parameter		Value	Units
V_{DS}	Drain-to-Source Voltage		20	V
V_{GS}	Gate-to-Source Voltage		±10	V
	Continuous Drain Current	T _A = 25°C	0.5	Α
I _D	Continuous Diain Current	T _A = 100°C	0.3	Α
I _{DM}	Pulsed Drain Current (1)		2	Α
P_{D}	Power Dissipation	T _A = 25°C	0.125	W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(2)	1000	°C/W
T_J,T_STG	Junction & Storage Temperature Range		-55 to 150	°C

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Electrical Characteristics (T_J = 25°C unless otherwise specified)

			,			
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Char	acteristics					
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	20	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 20V, V_{GS} = 0V$	-	-	1.0	μΑ
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 10V$	-	-	±10	μΑ
On Chara	acteristics				6	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250\mu A$	0.4	0.65	0.9	V
		$V_{GS} = 4.5V$, $I_D = 0.5A$	-	246	295	mΩ
$R_{DS(ON)}$	Static Drain-Source ON-Resistance ⁽³⁾	$V_{GS} = 2.5V, I_D = 0.3A$	-	368	441	mΩ
		$V_{GS} = 1.8V, I_D = 0.1A$	- /	619	743	mΩ
Dynamic	Characteristics					
C _{iss}	Input Capacitance		X - \	23	-	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 10V,$ f = 1MHz		6	-	pF
C_{rss}	Reverse Transfer Capacitance	I = IIVIMZ	U .	4	-	pF
Q_g	Total Gate Charge		-	0.4	-	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 4.5V$	-	0.04	-	nC
Q_{gd}	Gate Drain("Miller") Charge	$V_{DS} = 10V, I_{D} = 0.5A$	-	0.1	-	nC
Switchin	g Characteristics					
t _{d(on)}	Turn-On DelayTime	-\	-	0.8	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 4.5V, V_{DD} = 10V$	-	1.5	-	ns
$t_{d(off)}$	Turn-Off DelayTime	I_D = 0.5A, R_{GEN} = 6Ω	-	2.2	-	ns
t _f	Turn-Off Fall Time		-	1.7	-	ns
•	urce Diode Characteristics and N	lax Ratings				
I _s	Maximum Continuous Drain to Source Die		-	-	0.5	Α
I _{SM}	Maximum Pulsed Drain to Source Diode I	Forward Current	-	-	2	Α
V _{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 0.5A$	_	_	1.2	V
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Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

^{2.} R_{BJA} is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB

^{3.} Pulse Test: Pulse Width $\!\!\leqslant\! 300\mu s,$ Duty Cycle $\!\!\leqslant\! 0.5\%.$

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Test Circuit

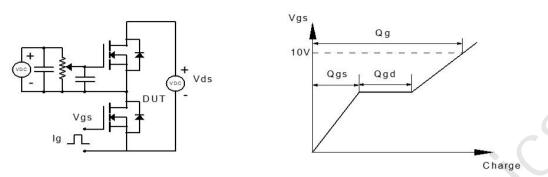


Figure 1: Gate Charge Test Circuit & Waveform

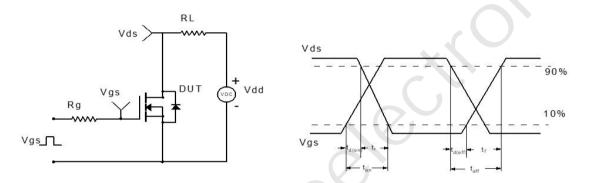


Figure 2: Resistive Switching Test Circuit & Waveform

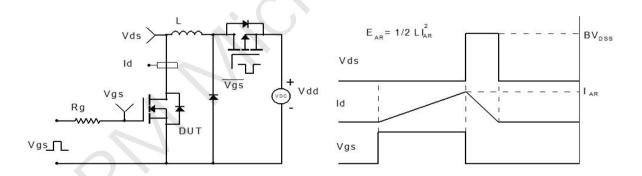


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

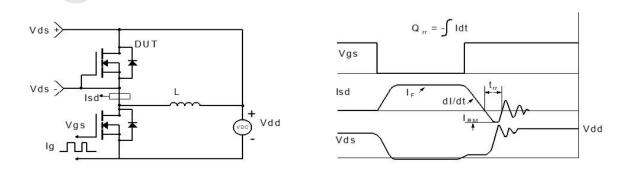
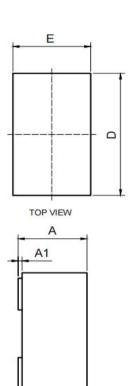


Figure 4: Diode Recovery Test Circuit & Waveform

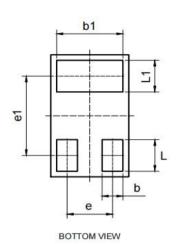
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Package Mechanical Data(DFN1006-3L)



SIDE VIEW



SYMBOL	MIN	NOM	MAX	
Α	0.45	0.50	0.55	
A1	0.00	NA	0.03	
L	0.22	0.26	0.30	
b	0.12	0.16	0.20	
D	0.95	1.00	1.05	
E	0.55	0.60	0.65	
L1	0.22	0.26	0.30	
b1	0.47	0.51	0.55	
е	0.35 BSC			
e1	0.65 BSC			

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Contact information

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